

Notice of References Cited

Application/Control No.

09/865,589

Applicant(s)/Patent Under
Reexamination
OONO ET AL.

Examiner

Donald Heckenberg

Art Unit

1722

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-5423669	06-1995	Chapman	425	143
	B	US-5676981	10-1997	Miyazawa et al.	425	112
	C	US-				
	D	US-				
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NON-PATENT DOCUMENTS

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